

**Notice of References Cited**Application Control No.  
**09/701,013**Applicant(s) Patent Under Reexam  
**Terada et al.**Examiner  
**Shin-Lin Chen**Art Unit  
**1632**

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**U.S. PATENT DOCUMENTS**

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY<sup>1</sup></small>	Name	Classification <sup>2</sup>
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